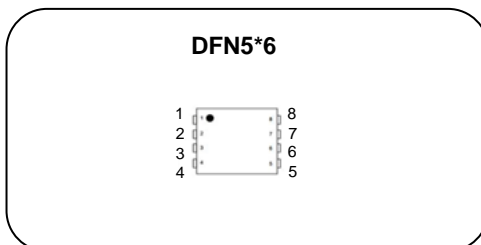


## Features

- High ruggedness
- Low  $R_{DS(ON)}$  (Typ 12mΩ)@ $V_{GS}=4.5V$   
(Typ 10.5mΩ)@ $V_{GS}=10V$
- Low Gate Charge (Typ 45nC)
- Improved dv/dt Capability
- 100% Avalanche Tested
- Application: DC-DC converter, Motor Control, Synchronous Rectification

## N-channel Enhanced mode DFN5\*6 MOSFET



4.Gate 5,6,7,8.Drain 1,2,3.Source

$BV_{DSS}$ : 45V
$I_D$ : 38A
$R_{DS(ON)}$ : 12mΩ@ $V_{GS}=4.5V$ 10.5mΩ@ $V_{GS}=10V$

## General Description

This power MOSFET is produced with advanced technology of SAMWIN. This technology enable the power MOSFET to have better characteristics, including fast switching time, low on resistance, low gate charge and especially excellent avalanche characteristics.



## Order Codes

Item	Sales Type	Marking	Package	Packaging
1	SW HA 120R45VT	SW120R45VT	DFN5*6	REEL

## Absolute maximum ratings

Symbol	Parameter	Value	Unit
$V_{DSS}$	Drain to source voltage	45	V
$I_D$	Continuous drain current (@ $T_C=25^{\circ}C$ )	38*	A
	Continuous drain current (@ $T_C=100^{\circ}C$ )	24*	A
$I_{DM}$	Drain current pulsed (note 1)	152	A
$I_{DSM}$	Continuous drain current (@ $T_a=25^{\circ}C$ )	11	A
	Continuous drain current (@ $T_a=70^{\circ}C$ )	9.5	A
$V_{GS}$	Gate to source voltage	±20	V
$E_{AS}$	Single pulsed avalanche energy (note 2)	145	mJ
$E_{AR}$	Repetitive avalanche energy (note 1)	11	mJ
dv/dt	Peak diode recovery dv/dt (note 3)	5	V/ns
$P_D$	Total power dissipation (@ $T_C=25^{\circ}C$ )	37.9	W
	Total power dissipation (@ $T_a=25^{\circ}C$ )	2.6	W
$T_{STG}, T_J$	Operating junction temperature & storage temperature	-55 ~ + 150	°C

\*. Drain current is limited by junction temperature.

## Thermal characteristics

Symbol	Parameter	Value	Unit
$R_{thjc}$	Thermal resistance, Junction to case	3.3	°C/W
$R_{thja}$	Thermal resistance, Junction to ambient	49	°C/W

Note:  $R_{thja}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{thjc}$  is guaranteed by design while  $R_{thca}$  is determined by the user's board design.



DFN5\*6  $R_{thja}$  : 49°C/W on a 1 in<sup>2</sup> pad of 2oz copper.

## Electrical characteristic ( $T_J=25^{\circ}\text{C}$ unless otherwise specified )

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
<b>Off characteristics</b>						
$BV_{DSS}$	Drain to source breakdown voltage	$V_{GS}=0V, I_D=250\mu A$	45			V
$\Delta BV_{DSS} / \Delta T_J$	Breakdown voltage temperature coefficient	$I_D=250\mu A$ , referenced to $25^{\circ}\text{C}$		0.04		$V/^{\circ}\text{C}$
$I_{DSS}$	Drain to source leakage current	$V_{DS}=45V, V_{GS}=0V$			1	$\mu A$
		$V_{DS}=36V, T_J=125^{\circ}\text{C}$			50	$\mu A$
$I_{GSS}$	Gate to source leakage current, forward	$V_{GS}=20V, V_{DS}=0V$			100	nA
	Gate to source leakage current, reverse	$V_{GS}=-20V, V_{DS}=0V$			-100	nA
<b>On characteristics</b>						
$V_{GS(TH)}$	Gate threshold voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	1		2.2	V
$R_{DS(ON)}$	Drain to source on state resistance	$V_{GS}=4.5V, I_D=5.5A, T_J=25^{\circ}\text{C}$		12	18	$m\Omega$
		$V_{GS}=10V, I_D=5.5A, T_J=25^{\circ}\text{C}$		10.5	15	$m\Omega$
		$V_{GS}=10V, I_D=5.5A, T_J=125^{\circ}\text{C}$		16.2		$m\Omega$
$G_{fs}$	Forward transconductance	$V_{DS}=5V, I_D=5.5A$		31		S
<b>Dynamic characteristics</b>						
$C_{iss}$	Input capacitance	$V_{GS}=0V, V_{DS}=22.5V, f=1\text{MHz}$		2105		pF
$C_{oss}$	Output capacitance			182		
$C_{riss}$	Reverse transfer capacitance			156		
$t_{d(on)}$	Turn on delay time	$V_{DS}=22.5V, I_D=11A, R_G=4.7\Omega, V_{GS}=10V$ (note 4,5)		8		ns
$t_r$	Rising time			50		
$t_{d(off)}$	Turn off delay time			55		
$t_f$	Fall time			17		
$Q_g$	Total gate charge	$V_{DS}=36V, V_{GS}=10V, I_D=11A, I_g=3mA$ (note 4,5)		45		nC
$Q_{gs}$	Gate-source charge			6		
$Q_{gd}$	Gate-drain charge			11		
$R_g$	Gate resistance		$V_{DS}=0V, \text{Scan F mode}$		3.4	

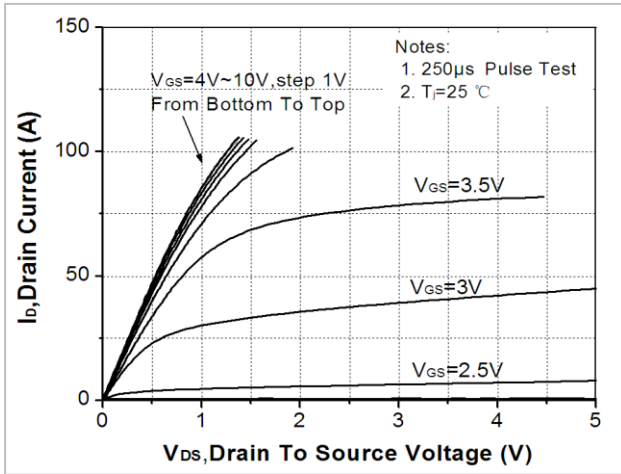
## Source to drain diode ratings characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_S$	Continuous source current	Integral reverse p-n Junction diode in the MOSFET			38	A
$I_{SM}$	Pulsed source current				152	A
$V_{SD}$	Diode forward voltage drop.	$I_S=11A, V_{GS}=0V$			1.4	V
$t_{rr}$	Reverse recovery time	$I_S=11A, V_{GS}=0V,$		14		ns
$Q_{rr}$	Reverse recovery charge	$di_F/dt=100A/us$		3		nC

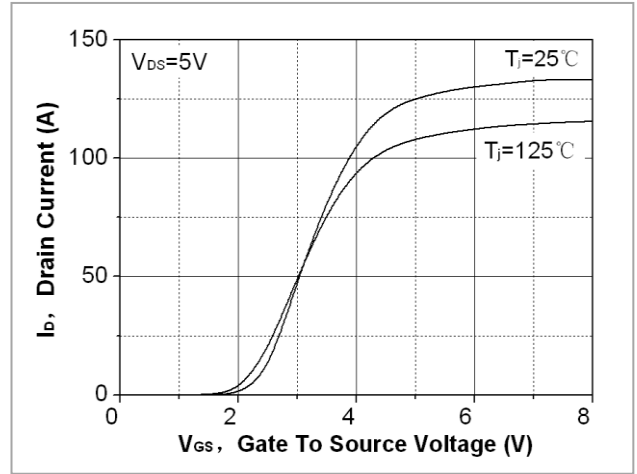
### ※. Notes

1. Repeattive rating : pulse width limited by junction temperature.
2.  $L=2.63mH, I_{AS}=10.5A, V_{DD}=50V, R_G=25\Omega$ , Starting  $T_J=25^{\circ}\text{C}$
3.  $I_{SD} \leq 11A, di/dt = 100A/us, V_{DD} \leq BV_{DSS}$ , Starting  $T_J=25^{\circ}\text{C}$
4. Pulse Test : Pulse Width  $\leq 300us$ , duty cycle  $\leq 2\%$ .
5. Essentially independent of operating temperature.

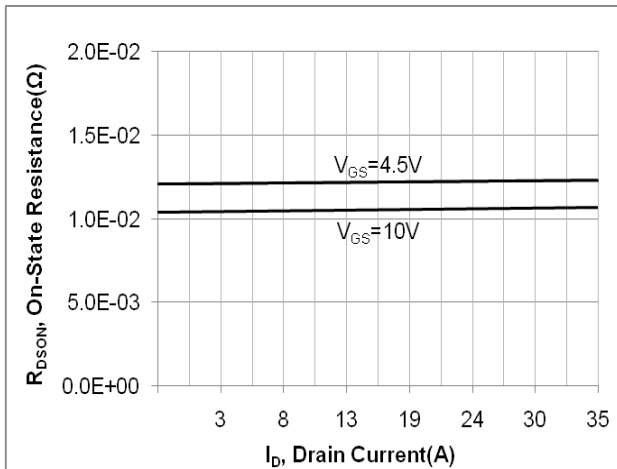
**Fig. 1. On-state characteristics**



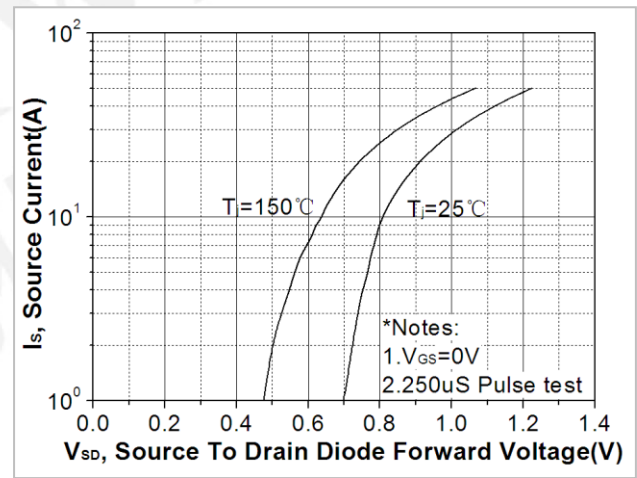
**Fig. 2. Transfer Characteristics**



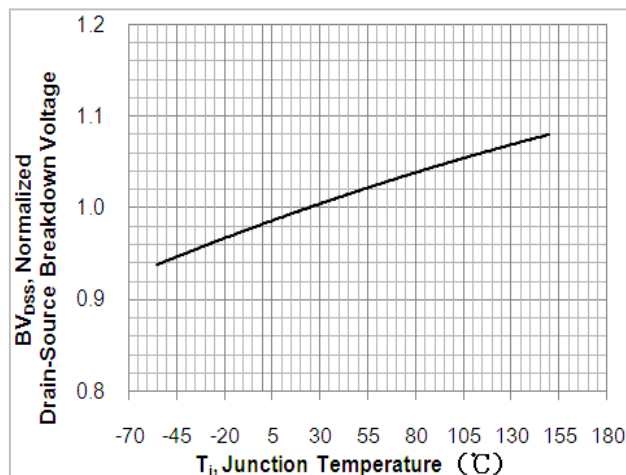
**Fig. 3. On-resistance variation vs. drain current and gate voltage**



**Fig. 4. On-state current vs. diode forward voltage**



**Fig 5. Breakdown voltage variation vs. junction temperature**



**Fig. 6. On-resistance variation vs. junction temperature**

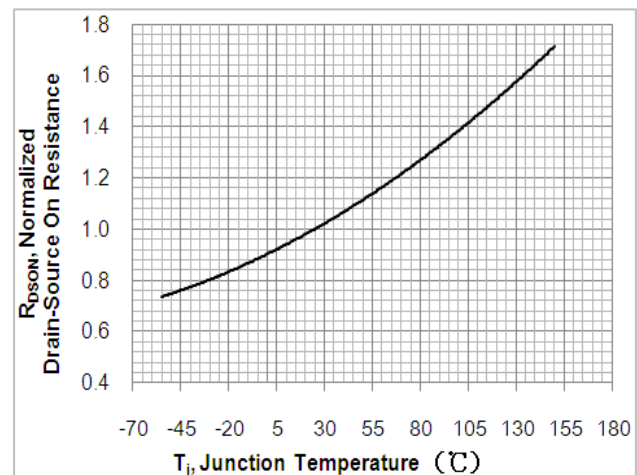


Fig. 7. Gate charge characteristics

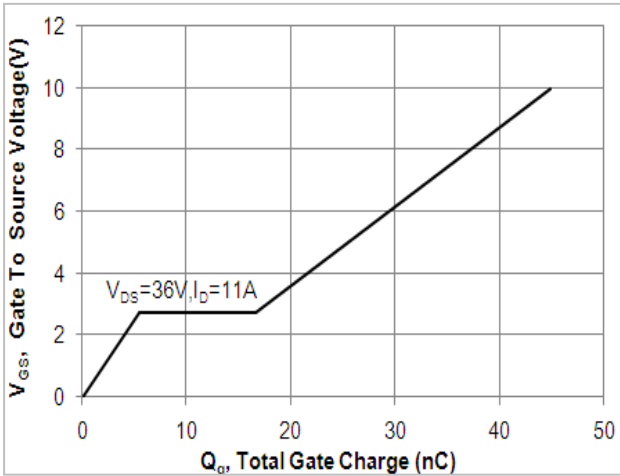


Fig. 8. Capacitance Characteristics

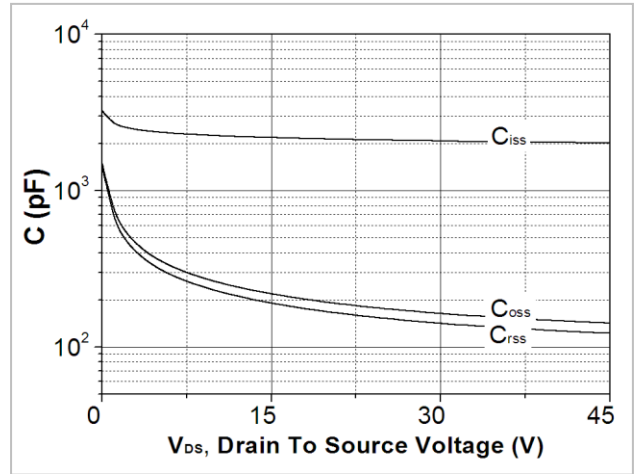


Fig. 9. Maximum safe operating area

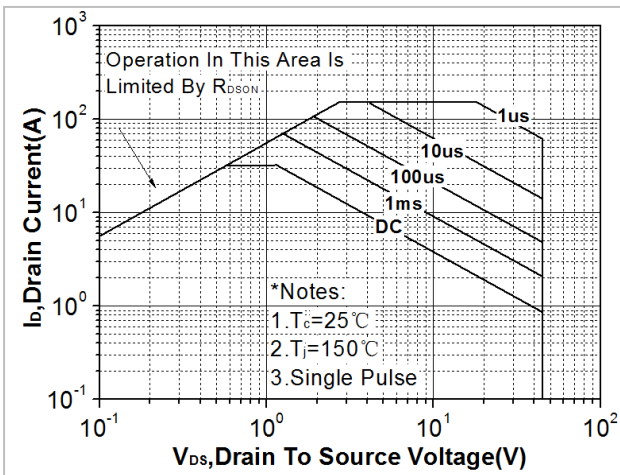


Fig. 10. Maximum drain current vs. case temperature

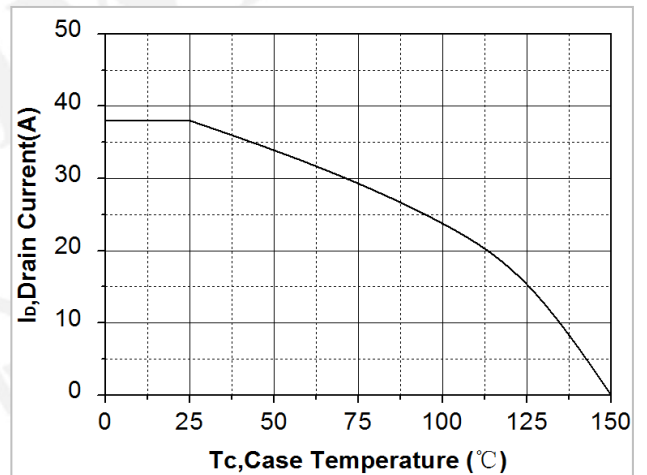


Fig. 11. Transient thermal response curve

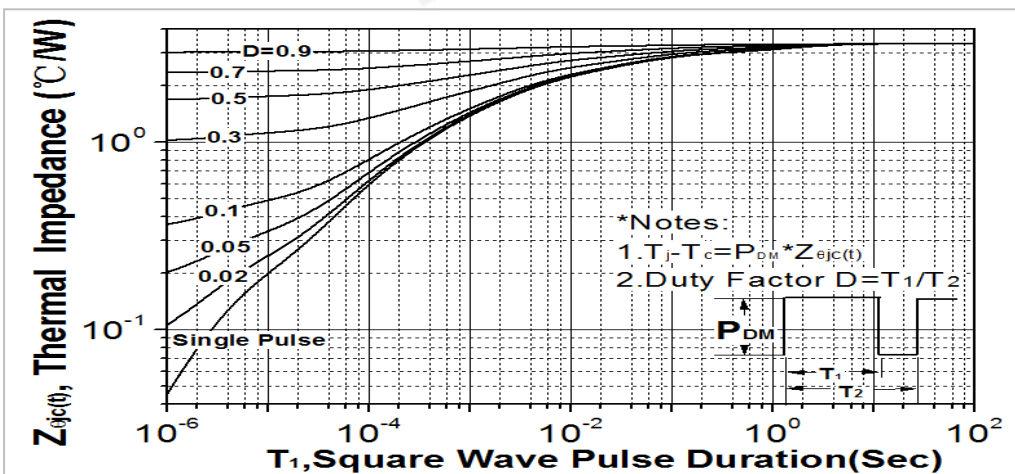


Fig. 12. Gate charge test circuit & waveform

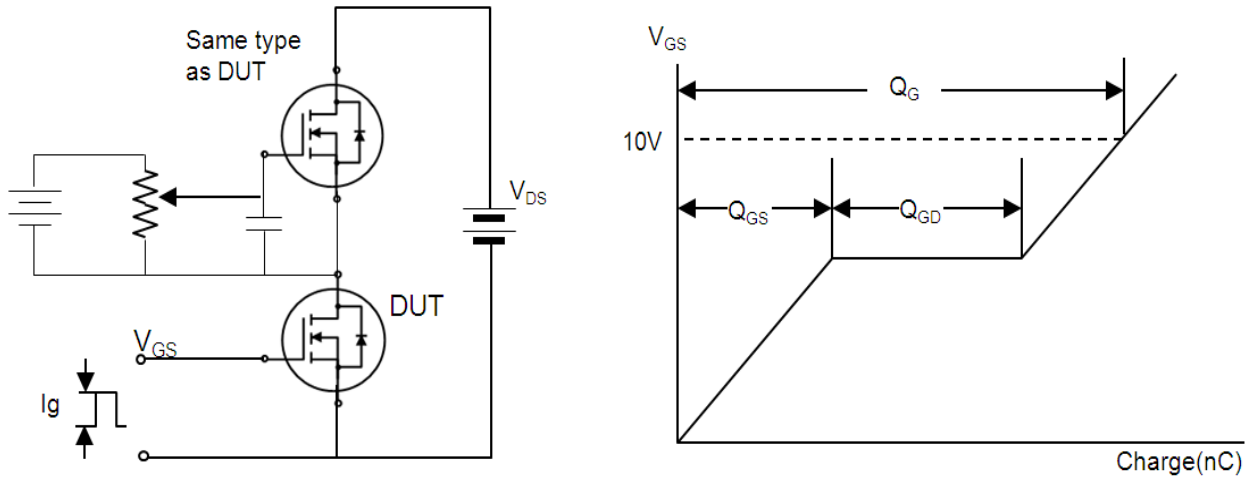


Fig. 13. Switching time test circuit & waveform

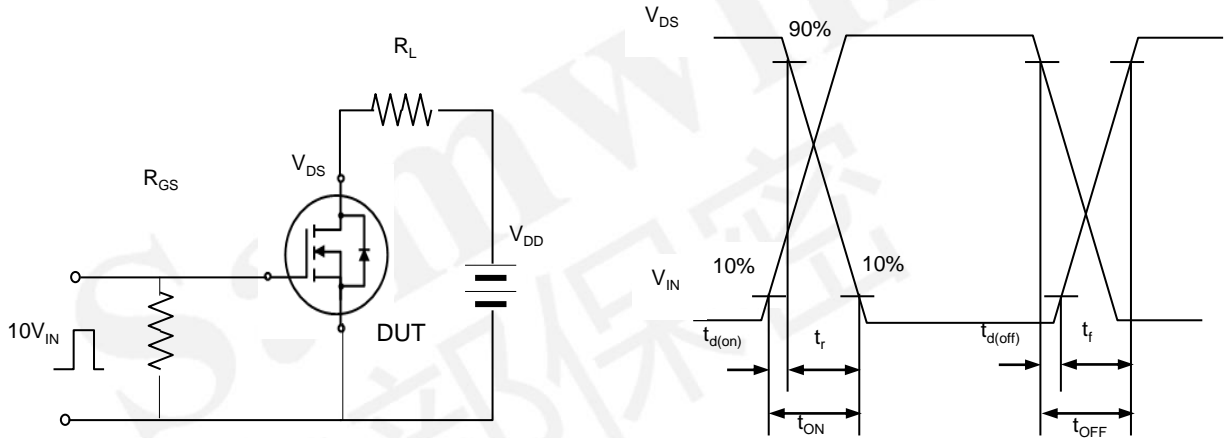


Fig. 14. Unclamped Inductive switching test circuit & waveform

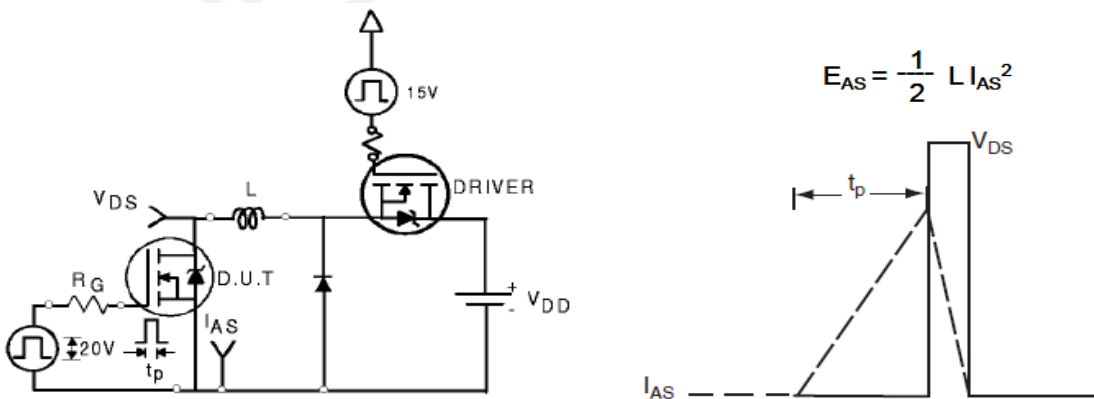
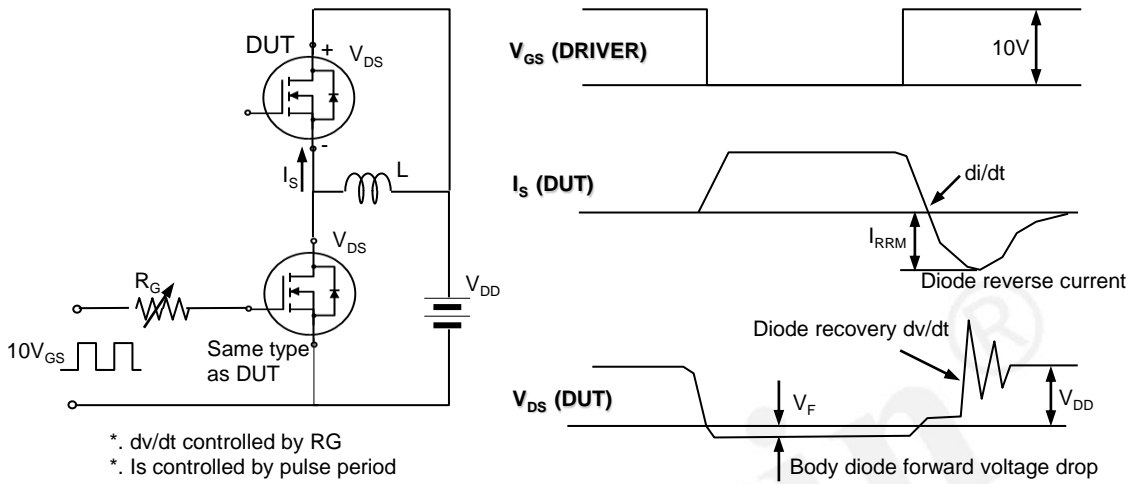



Fig. 15. Peak diode recovery dv/dt test circuit & waveform



### DISCLAIMER

- \* All the data & curve in this document was tested in SEMIPOWER TESTING & APPLICATION CENTER.
- \* This product has passed the PCT,TC,HTRB,HTGB,HAST,PC and Solderdunk reliability testing.
- \* Qualification standards can also be found on the Web site (<http://www.semipower.com.cn>) 
- \* Suggestions for improvement are appreciated, Please send your suggestions to [samwin@samwinsemi.com](mailto:samwin@samwinsemi.com)

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